

Digital IC Design

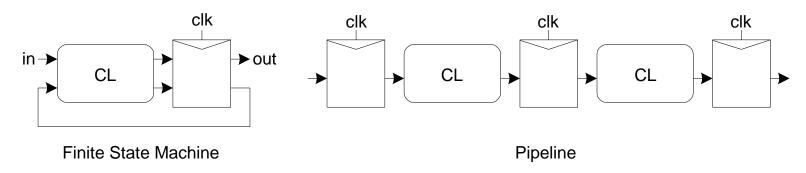
Lecture 19 Metastability and Synchronizers

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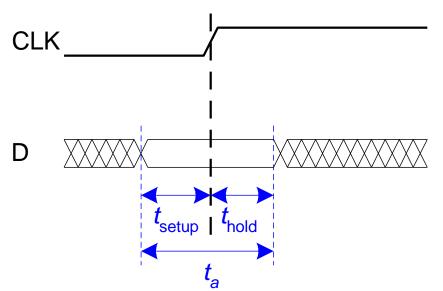
Combinational vs. Sequential Logic

- Combinational logic
 - Output depends on current inputs
- Sequential logic
 - Output depends on current and previous inputs
 - Uses flip-flops or latches (memory/sequencing elements)
 - Separates previous, current, and next states (tokens)
 - Ex: FSM, pipeline



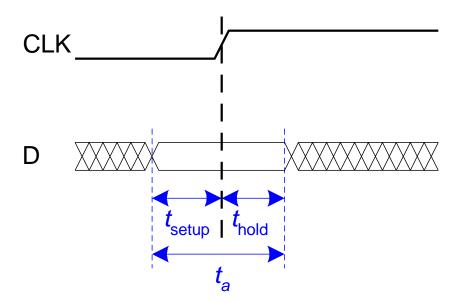
FF Input Timing Constraints

- ☐ Flip-flop samples *D* at clock edge
 - D must be stable when sampled
 - Similar to a photograph, D must be stable around clock edge
 - If not, metastability can occur
- \Box Setup time: t_{setup} = time *before* clock edge data must be stable (i.e. not changing)
- \Box Hold time: t_{hold} = time *after* clock edge data must be stable
- \Box Aperture time: t_a = time *around* clock edge data must be stable (t_a = t_{setup} + t_{hold})



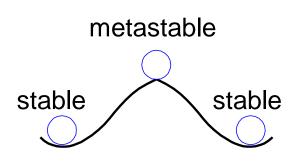
FF Input Timing Constraints

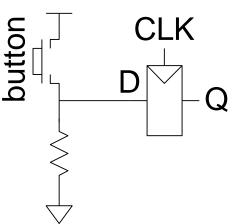
- If data changes in the aperture between the setup and hold times
 - Latch enters a metastable state
 - Output may be unpredictable
 - Time to settle to a good logic level may be unbounded

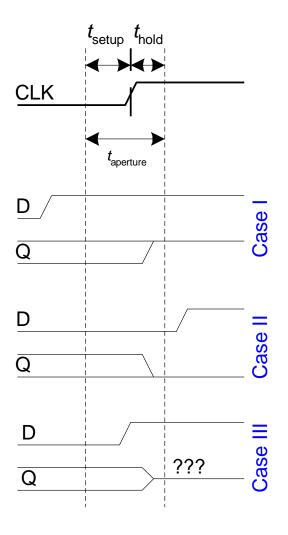


Violating the Dynamic Discipline

- ☐ Asynchronous inputs may violate the dynamic discipline
 - Asynchronous inputs are inevitable (user inputs, MCU interrupts, systems with different clocks interacting, etc.)
 - Multiple clock domains exist on the same chip: on-chip data crosses the clock domain boundaries.
- ☐ Flip-flop is a bistable device
 - Two stable states (1 and 0) and one metastable state
 - If flip-flop lands in metastable state, could stay there for an undetermined amount of time

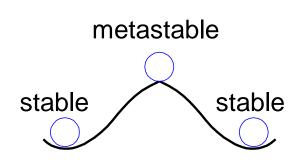


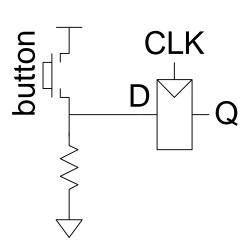


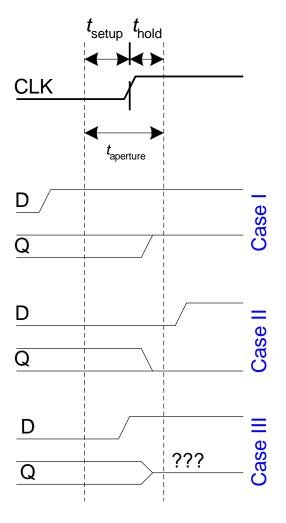


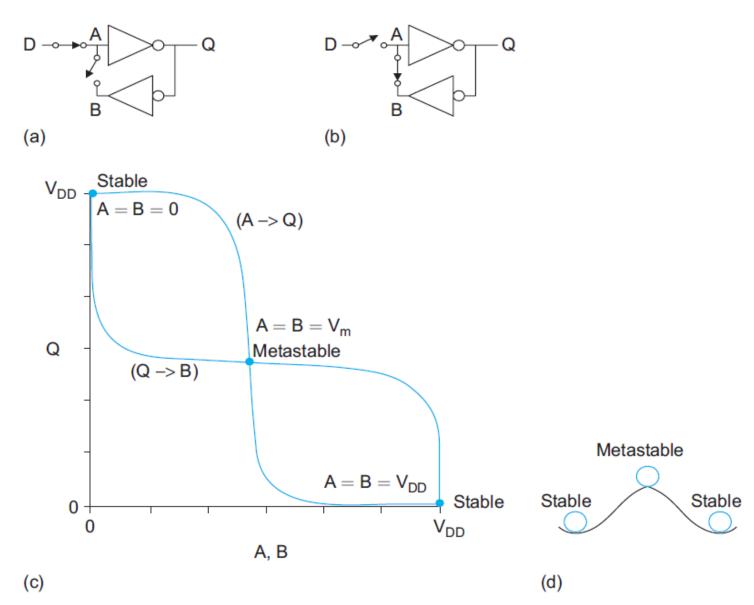
Synchronizers

- ☐ Unsynchronized inputs can cause strange and sporadic system failures that are very difficult to locate
- Synchronizer: a circuit that accepts an input that can change at arbitrary times and produces an output aligned to the synchronizer's clock
- ☐ Synchronizer goal: make the probability of failure (the output Q still being metastable) **low**
 - Synchronizer cannot make the probability of failure 0

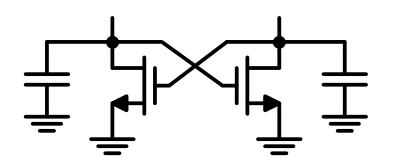








Regenerative Latch Delay



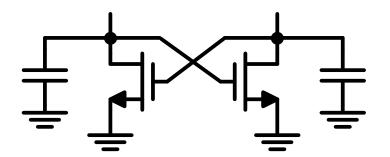
Regenerative Latch Delay

lacktriangle Assume the pre-amplified latch input voltage = ΔV_{in}

$$\tau \approx \frac{C}{g_m}$$

$$\Delta V_{out}(t) = \Delta V_{in} e^{+t/\tau}$$

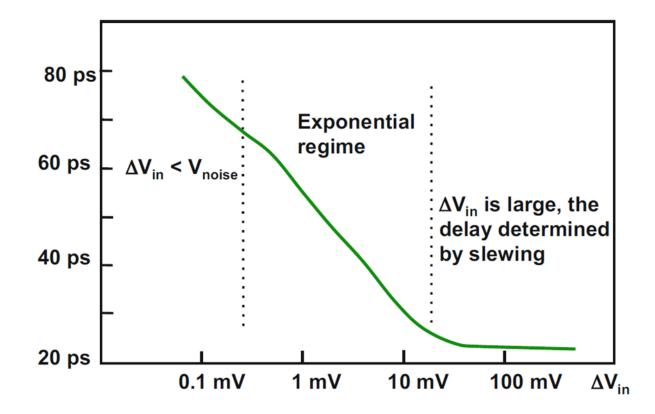
- ☐ The exponential signal growth makes a latch a fast decision element
- The exponential growth will continue until some non-linear limiting mechanism takes action (e.g., approaching power rails)



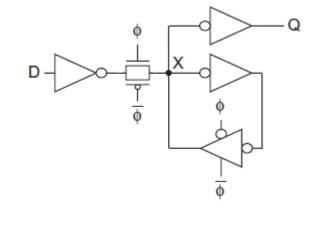
Regenerative Latch Delay

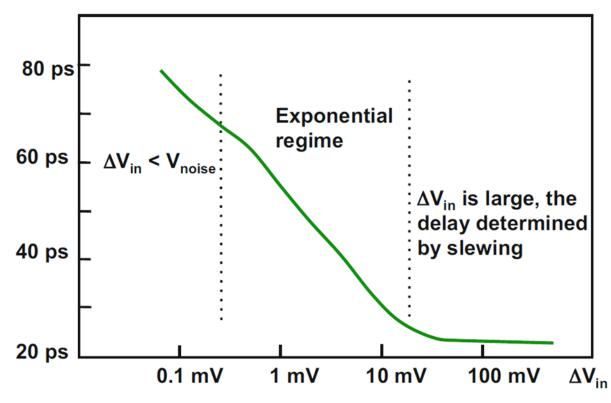
- The time a latch needs to form a digital signal depends on the initial over-drive voltage
 - The input differential voltage (ΔV_{in}) determines the delay of the latch

$$\Delta V_{out}(t) = \Delta V_{in} e^{+t/\tau} \rightarrow t_d = \tau \ln \frac{V_{DD}}{\Delta V_{in}} = \tau (\ln V_{DD} - \ln \Delta V_{in})$$

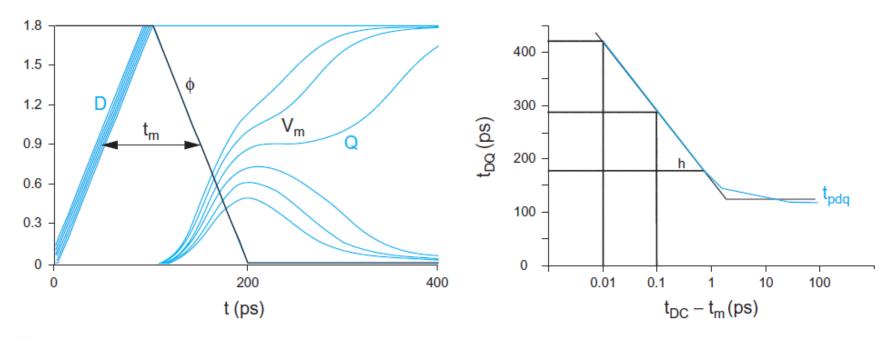


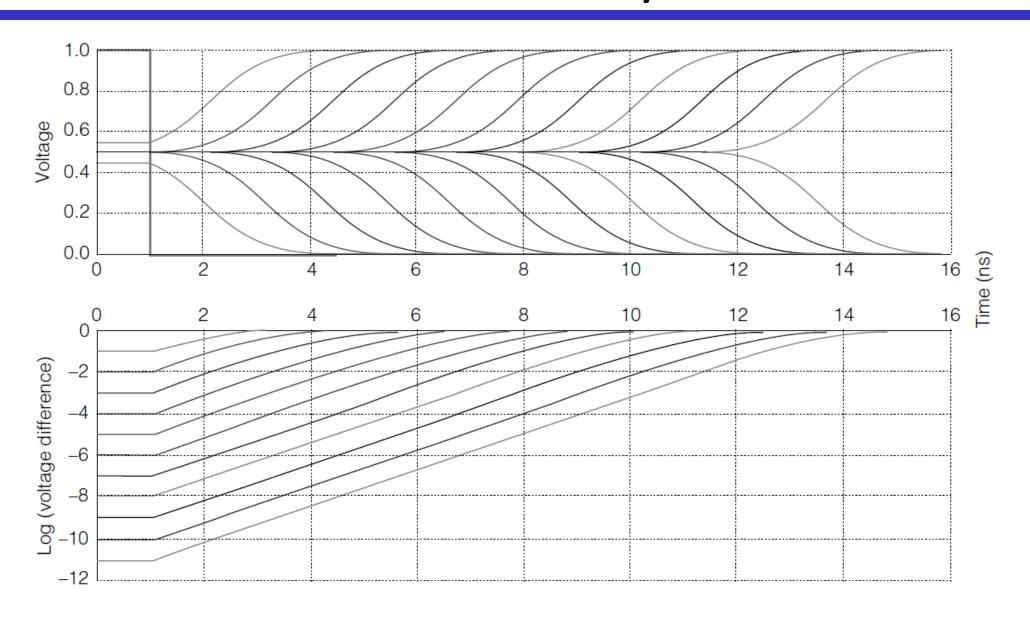
- lacktriangle For very small overdrive voltages, the latch/FF cannot reach a decision within its propagation delay $(t_{pDQ} \ / \ t_{pCQ})$
 - The latch/FF will not generate a clear "zero" or "one" output level before t_{pDQ} / t_{pCQ}





- lacktriangle Delay increases for inputs that arrive too close to t_m
- The time to resolve from metastability depends on the gain-bandwidth product (GBW=1/ au) of the latch feedback loop
- \Box Delay increases for inputs that arrive too close to t_m
- \Box The time to resolve from metastability depends on the gain-bandwidth product (GBW=1/ au) of the latch feedback loop





Probability of Metastability

- $lue{\Box}$ Probability of Metastability (MS) is the probability that the asynchronous input edge occurs in the metastability window (T_W)
 - Metastability can be simply defined as FF output delay > t_{pCQ}

$$T_W \sim t_a = t_{setup} + t_{hold}$$

$$P(MS) = \frac{T_W}{T_C} = T_W f_C$$

Mean Time Between Failures (MTBF)

$$P(MS) = \frac{T_W}{T_C} = T_W f_C$$

- ☐ Assume the asynchronous input changes once per second
 - Probability of MS per second = probability of failure per second = Failure Rate = P(MS)
- \Box If input changes at a rate of f_{in} (i.e., f_{in} times per second)
 - Probability of failure per second = Failure Rate (FR) = BER = $f_{in} \frac{T_W}{T_C} = T_W f_{in} f_C$
- \Box Failure happens (on average) every 1/FR
 - Called mean time between failures (MTBF)

$$MTBF = \frac{1}{FR} = \frac{1}{T_W f_{in} f_C}$$

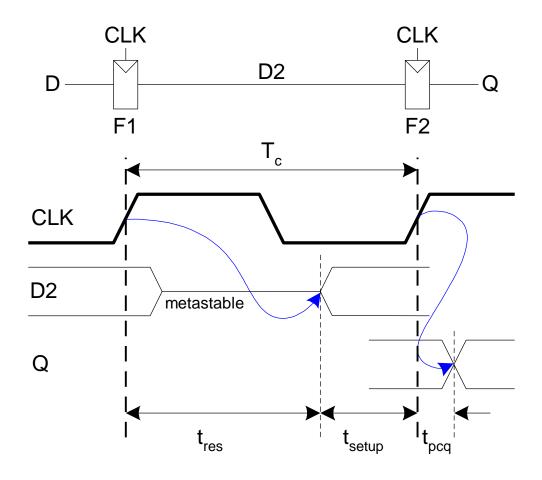
Assume $f_C = 1$ GHz, $f_{in} = 100$ MHz, $T_W = 20$ ps $P(MS) = \frac{T_W}{T_C} = T_W f_C = 0.02$

$$FR = T_W f_{in} f_C = 2M/s$$

$$MTBF = \frac{1}{FR} = \frac{1}{T_W f_{in} f_C} = 0.5 \mu s$$

Simple Synchronizer

- ☐ Give the metastable signal extra time to resolve
 - Add one more FF to give one more clock cycle
 - The more FFs you add, the more time you give



Probability of Synchronizer Failure

 \square Assume ambiguity happens when $\Delta V_{out}(t_{res}) < V_{DD}$

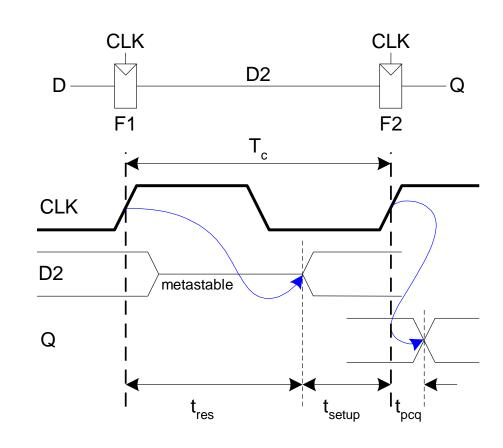
$$\Delta V_{out} (t_{res}) = \Delta V_{in} e^{+t_{res}/\tau} < V_{DD}$$

$$\Delta V_{in,min} = V_{DD}e^{-t_{res}/\tau}$$

 \square Assume ΔV_{in} is uniformly distributed:

$$0 < \Delta V_{in} < V_{DD}$$
$$0 < \Delta V_{in} / V_{DD} < 1$$

$$P(Sync\ Failure) = \frac{\Delta V_{in,min}}{V_{DD}} = e^{-(T_C - t_{setup})/\tau}$$



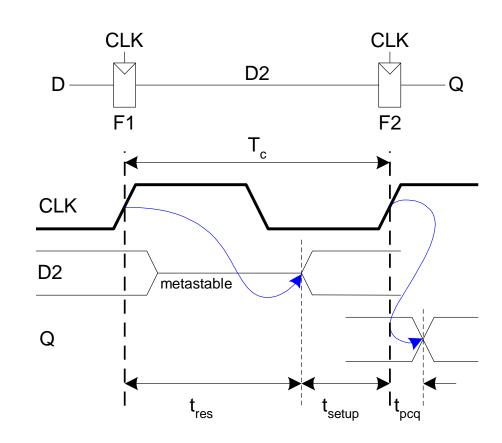
Probability of Failure

$$P(Sync\ Failure) = e^{-(T_C - t_{Setup})/\tau}$$

■ But the problem occurs only when the latch is metastable!

$$P(Failure) = P(MS) \times P(Sync\ Failure)$$

= $T_W f_C e^{-(T_C - t_{setup})/\tau}$



Synchronizer Mean Time Between Failures (MTBF)

- \Box If input changes at a rate of f_{in} (i.e., f_{in} times per second)
 - Probability of failure per second = Failure Rate (FR) = $T_W f_{in} f_C e^{-(T_C t_{setup})/\tau}$
- \Box Failure happens (on average) every 1/FR
 - Called mean time between failures (MTBF)

$$MTBF = \frac{1}{FR} = \frac{e^{+(T_C - t_{setup})/\tau}}{T_W f_{in} f_C}$$

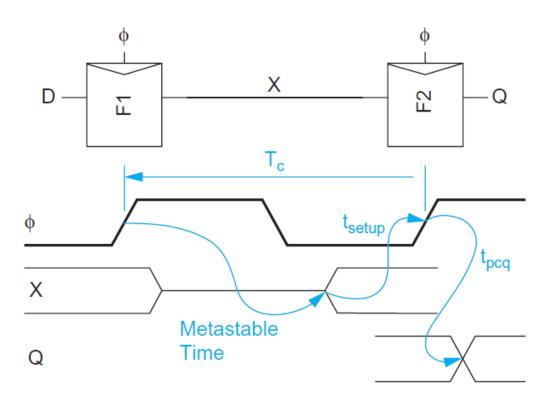
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Simple Synchronizer Summary

- \square The synchronizer has a latency of one clock cycle (T_C) .
- \Box Fails if X does not settle t_{setup} before the second clock edge.
- MTBF: Mean time between failures
- \Box f_{in} : asynchronous input toggling rate
- \Box $T_W/T_c = T_W f_C$ describes the probability of change during the aperture
- \Box τ : latch time constant (= 1/GBW)

$$MTBF = \frac{1}{FR}$$

$$= \frac{e^{+(T_C - t_{setup})/\tau}}{T_W f_{in} f_C}$$

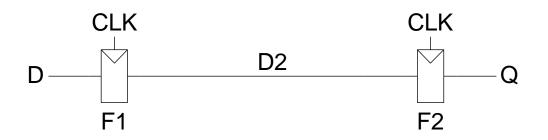


Δ Assume:
$$T_c = 1/500 \text{ MHz} = 2 \text{ ns}$$
 $\tau = 200 \text{ ps}$

$$T_W = 150 \text{ ps}$$
 $t_{setup} = 100 \text{ ps}$

f_{in} = 10 events per second

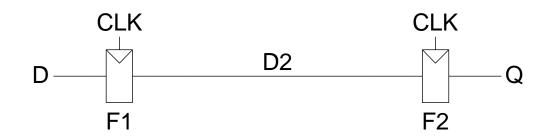
☐ What is the probability of failure? MTBF?



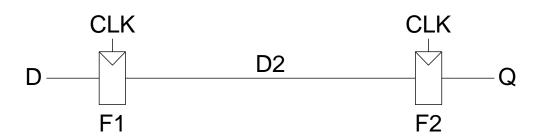
Assume:
$$T_c = 1/500 \text{ MHz} = 2 \text{ ns}$$
 $\tau = 200 \text{ ps}$

$$T_W = 150 \text{ ps}$$
 $t_{setup} = 100 \text{ ps}$

- ☐ What is the probability of failure? MTBF?
- $P(failure) = (150 \text{ ps/2 ns}) e^{-(1.9 \text{ ns})/200 \text{ ps}}$ = 5.6e-6
- \Box FR = P(failure)/second = 10 × (5.6e-6)
 - = 5.6e-5 / second

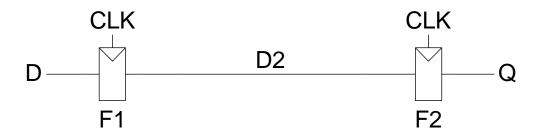


- A synchronizer flip-flop in a 0.25 μ m process has τ = 20 ps and T_W = 15 ps. Assuming the input toggles at f_{in} = 50 MHz and the setup time is negligible, what is the minimum clock period T_c for which the MTBF exceeds one year?
 - 1 year $\approx \pi \times 10^7$ seconds



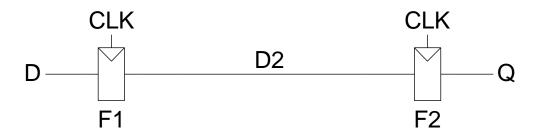
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 - 1 year $\approx \pi \times 10^7$ seconds
 - Solve numerically
 - $T_c \approx 625ps (1.6GHz)$
- \Box If MTBF = 1000 years
 - $T_c \approx ?$

$$\pi \times 10^7 = \frac{T_c}{\left(5 \times 10^7\right) \left(15 \times 10^{-12}\right)}$$

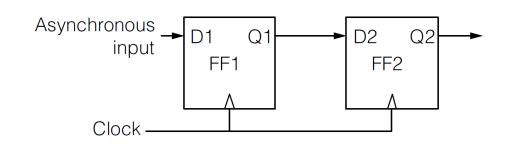


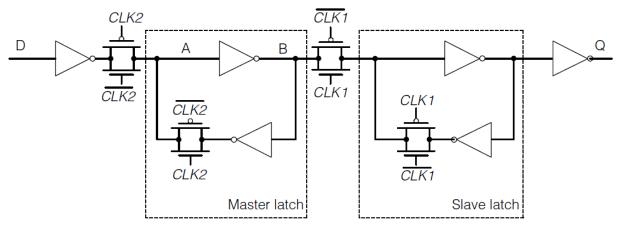
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 - 1 year $\approx \pi \times 10^7$ seconds
 - Solve numerically
 - $T_c \approx 625ps (1.6GHz)$
- \Box If MTBF = 1000 years
 - $T_c \approx 760ps (1.3GHz)$
 - Exponential dependence on $T_c!!!$

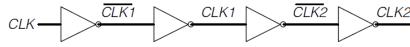
$$\pi \times 10^7 = \frac{T_c}{\left(5 \times 10^7\right) \left(15 \times 10^{-12}\right)}$$

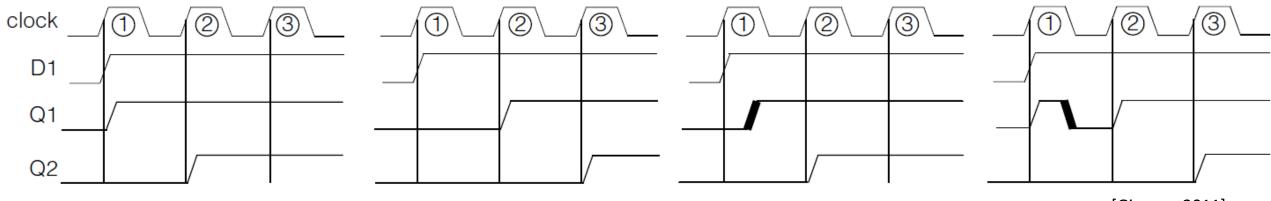


Synchronizer Behavior



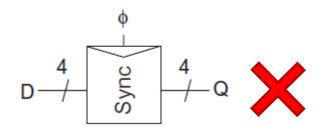


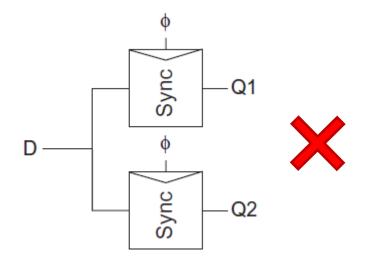




Synchronization Pitfalls

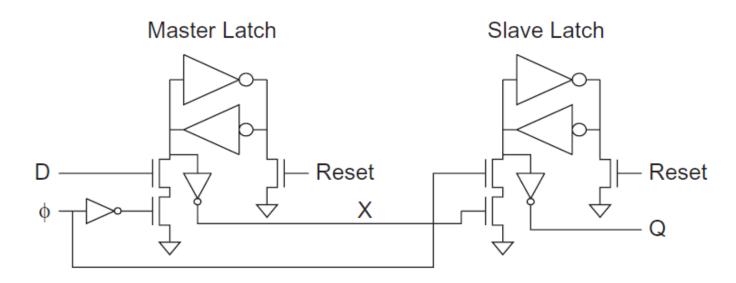
- ☐ Do NOT synchronize data lines
 - Unless gray codes are used (only one bit changes at a time)
 - Some bits will pass after one cycle and others after two cycles
- Do NOT drive two synchronizers with the same signal
 - The two synchronizers can resolve to different values
- ☐ Do NOT put the sync FFs far apart
 - The wire delay will eat from your resolution time
- Synchronizers must have good feedback loops
 - You cannot use dynamic FFs
- Overall MTBF depends on number of synchronizers





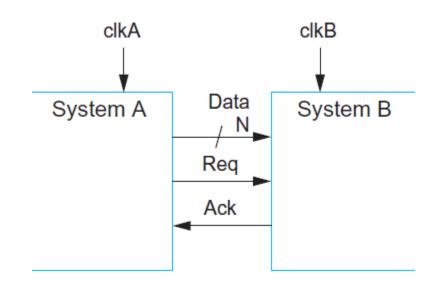
Synchronizer Flip-Flop

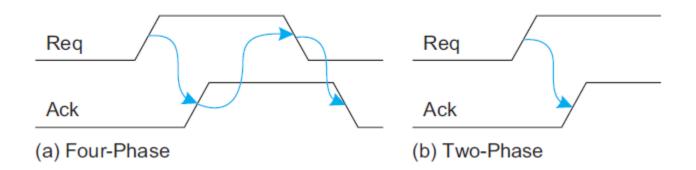
- ☐ Master and slave jamb latches
- \blacksquare Maximize feedback loop GBW (minimizes $au = \mathcal{C}_L/g_m$)
 - Simple cross-coupled inverter pair
 - Minimize loading on feedback loop
 - Reset to 0 and only set to 1 if D = 1
 - PDN just large enough to overpower the cross-coupled pair
 - X and Q are buffered with small inverters



Asynchronous Communication

- Multiple clock domains
- Handshake protocol
 - Four-phase: level-sensitive
 - Two-phase: edge-sensitive
- Synchronizers required for handshake lines (Request & Ack)





19: Metastability and Synchronizers

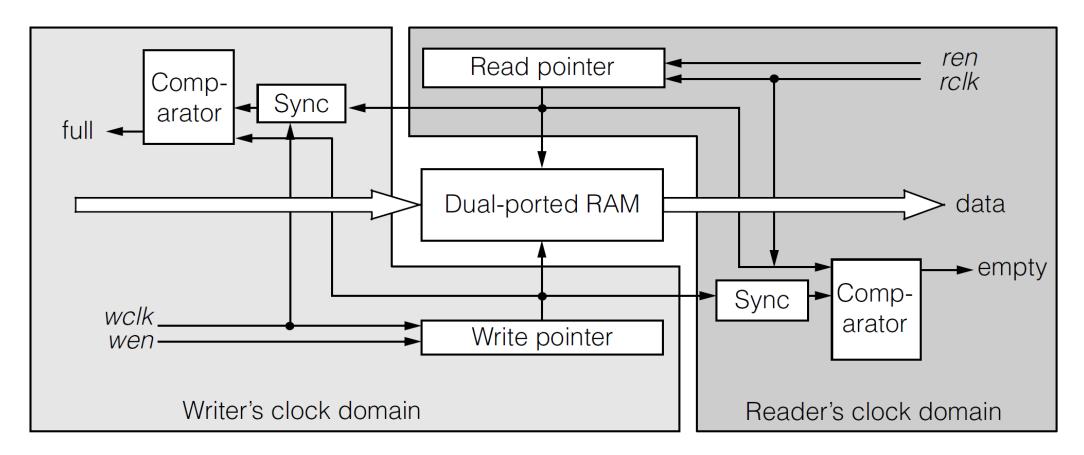
Two-Phase Handshake Example

Significant latency added, much lower throughput System A System B Data DataB DataA ReqA Req ReqB Pulse Synchronizer to edge Edge to AckB Ack pulse Synchronizer clkB ReqA Req ReqB/AckB Ack

19: Metastability and Synchro AckA

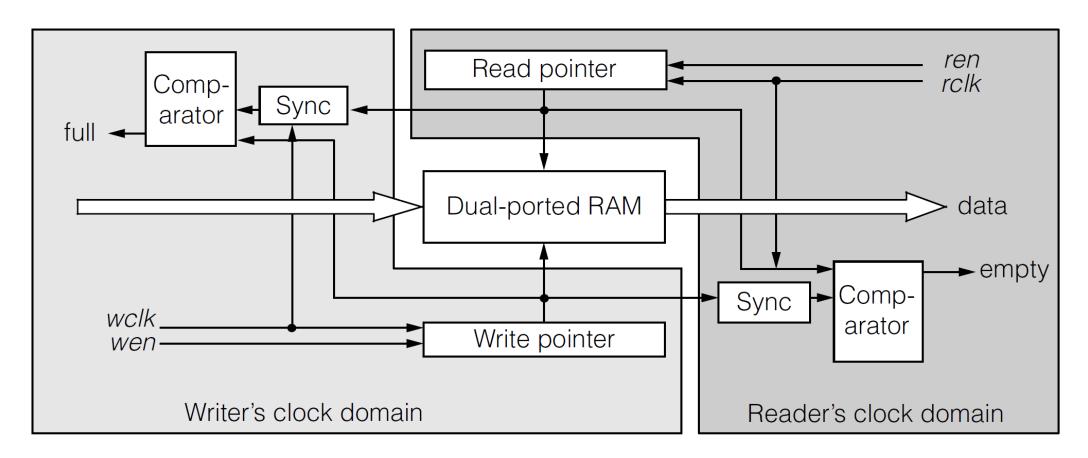
Two-clock FIFO Buffer

- ☐ High-throughput asynchronous communication
- Typically available as library element or IP core
- ☐ On write and on read, the write pointer and the read pointer are respectively incremented.

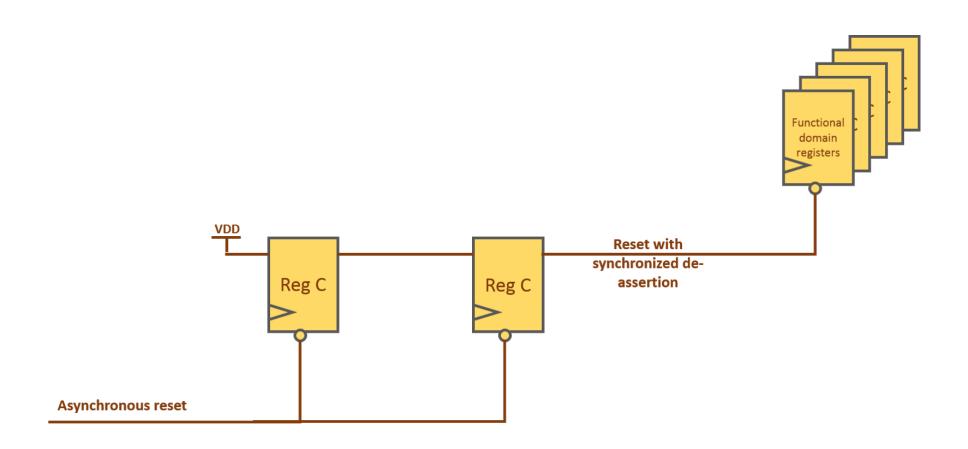


Two-clock FIFO Buffer

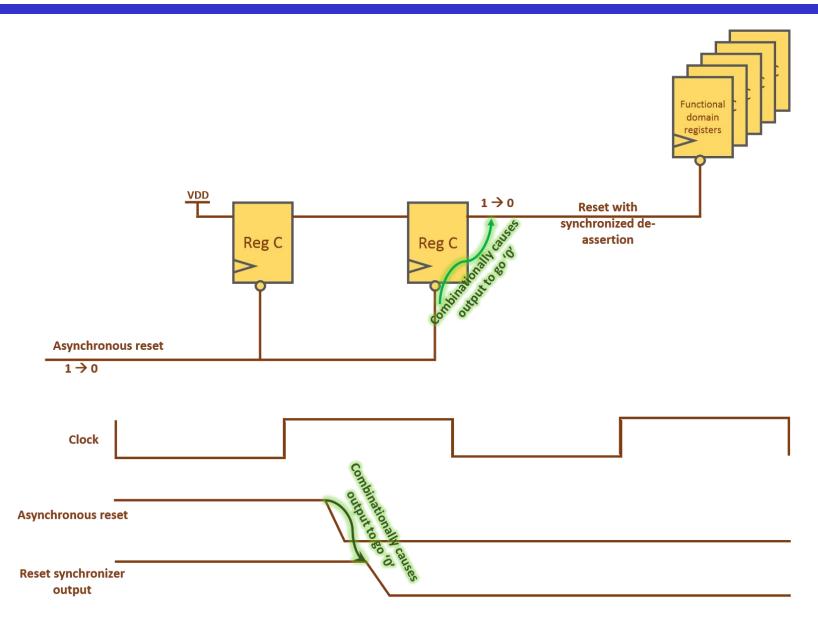
- ☐ Empty: When the read pointer points to the same word as the write pointer
- Synchronization is applied to the pointers NOT to the data (pointers are in gray code)
- ☐ When the two pointers are far from each other, no synchronization latency is incurred



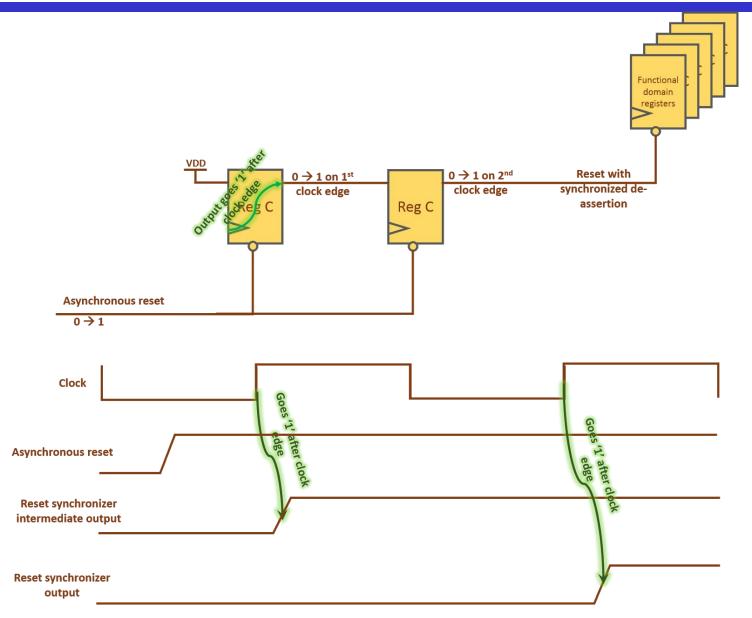
Reset Synchronization



Reset Synchronization



Reset Synchronization



Degrees of Synchrony

- Several "smart" solutions were proposed for the spectrum between sync and async
- But the two-clock FIFO is the simplest, safest, and most popular solution

Classification	Periodic	$\Delta \phi$	Δf	Description
Synchronous	Yes	0	0	Signal has same frequency and phase as clock. Safe to sample signal directly with the clock. Example: Flip-flop to flip-flop on chip.
Mesochronous	Yes	Constant	0	Signal has same frequency, but is out of phase with the clock. Safe to sample signal if it is delayed by a constant amount to fall outside aperture. Example: Chip-to-chip where chips use same clock signal, but might have arbitrarily large skews.
Plesiochronous	Yes	Varies slowly	Small	Signal has nearly the same frequency. Phase drifts slowly over time. Safe to sample signal if it is delayed by a variable but predictable amount. Difference in frequency can lead to dropped or duplicated data. Example: Board-to-board where boards use clock crystals with small mismatches in nominally identical rates.
Periodic	Yes	Varies rapidly	Large	Signal is periodic at an arbitrary frequency. Periodic nature can be exploited to predict and delay accordingly when data will change during aperture. Example: Board-to-board where boards use different frequency clocks.
Asynchronous	No	Unknown	Unknown	Signal may change at arbitrary times. Full synchronizer is required. Example: Input from pushbutton switch.

More on Metastability

M. Arora, The Art of Hardware Architecture: Design Methods and Techniques for Digital Circuits, Springer, 2012.

https://link.springer.com/book/10.1007%2F978-1-4614-0397-5

□ R. Ginosar, "Metastability and Synchronizers: A Tutorial," *IEEE Design & Test of Computers*, 2011.

Thank you!